

Data Sheet Issue:- P1

Medium Voltage Thyristor Types K2325TJ600 & K2325TJ650

Absolute Maximum Ratings

	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
Vdrm	Repetitive peak off-state voltage, (note 1)	6000-6500	V
V _{DSM}	Non-repetitive peak off-state voltage, (note 1)	6000-6500	V
Vrrm	Repetitive peak reverse voltage, (note 1)	6000-6500	V
V _{RSM}	Non-repetitive peak reverse voltage, (note 1)	6100-6600	V

	OTHER RATINGS	MAXIMUM LIMITS	UNITS
I _{T(AV)}	Mean on-state current. T _{sink} =55°C, (note 2)	2380	А
It(av)	Mean on-state current. T _{sink} =85°C, (note 2)	1685	А
I _{T(AV)}	Mean on-state current. T _{sink} =85°C, (note 3)	900	А
I _{T(RMS)}	Nominal RMS on-state current. T _{sink} =25°C, (note 2)	4625	А
I _{T(d.c.)}	D.C. on-state current. T _{sink} =25°C, (note 4)	4195	А
I _{TSM}	Peak non-repetitive surge t _p =10ms, V _{RM} =0.6V _{RRM} , (note 5)	33.0	kA
ITSM2	Peak non-repetitive surge $t_p=10ms$, $V_{RM} \le 10V$, (note 5)	36.3	kA
l²t	$I^{2}t$ capacity for fusing t _p =10ms, V _{RM} =0.6V _{RRM} , (note 5)	5.45×10 ⁶	A ² s
l²t	$I^{2}t$ capacity for fusing t _p =10ms, V _{RM} ≤10V, (note 5)	6.59×10 ⁶	A ² s
al: /al#	Maximum rate of rise of on-state current (repetitive), (Note 6)	200	A/µs
di⊤/dt	Maximum rate of rise of on-state current (non-repetitive), (Note 6)	1000	A/µs
V _{RGM}	Peak reverse gate voltage	5	V
P _{G(AV)}	Mean forward gate power	5	W
P _{GM}	Peak forward gate power	40	W
Vgd	Non-trigger gate voltage, (Note 7)	0.25	V
Т _{нs}	Operating temperature range	-40 to +125	°C
T _{stg}	Storage temperature range	-40 to +150	°C

Notes: -

- 1) De-rating factor of 0.13% per °C is applicable for T_j below 25°C.
- 2) Double side cooled, single phase; 50Hz, 180° half-sinewave.
- 3) Cathode side cooled, single phase; 50Hz, 180° half-sinewave.
- 4) Double side cooled.
- 5) Half-sinewave, 125°C T_j initial.
- 6) V_D=67% V_DRM, I_TM=4000A, I_FG=2A, t_r \le 0.5 \mu s, T_{case}=125 ^{\circ}C.
- 7) Rated V_{DRM} .

Characteristics

	PARAMETER	MIN.	TYP.	MAX.	TEST CONDITIONS (Note 1)	UNITS
Vтм	Maximum peak on-state voltage	-	-	2.50	I _{TM} =3000A	V
Vтм	Maximum peak on-state voltage	-	-	4.20	Ітм=7140А	V
V ₀	Threshold voltage	-	-	1.26		V
r⊤	Slope resistance	-	-	0.41		mΩ
dv/dt	Critical rate of rise of off-state voltage	1000	-	-	V _D =80% V _{DRM} , Linear ramp, gate o/c	V/µs
Idrm	Peak off-state current	-	-	200	Rated V _{DRM}	mA
Irrm	Peak reverse current	-	-	200	Rated V _{RRM}	mA
Vgt	Gate trigger voltage	-	-	3.0		V
I _{GT}	Gate trigger current	-	-	300	Tj=25°C, VD=10V, IT=3A	mA
Ін	Holding current	-	-	1000	Tj=25°C	mA
t _{gd}	Gate controlled turn-on delay time	-	0.7	1.5	I _{FG} =2A, t _r =0.5μs, V _D =67%V _{DRM} ,	
t _{gt}	Turn-on time	-	1.5	3.0	I _{TM} =2400A, di/dt=10A/μs, T _j =25°C	μs
Qrr	Recovered Charge	-	11	12		mC
Qra	Recovered Charge, 50% chord	-	5.2	-	I _{TM} =3000A, t _p =2000µs, di/dt=10A/µs,	mC
Irm	Reverse recovery current	-	210	220	Vr=100V	А
trr	Reverse recovery time, 50% chord	-	50	-		μs
		1050	-	1300	I _{TM} =3000A, t _P =1000µs, di/dt=10A/µs, V _r =100V, V _{dr} =80%V _{DRM} , dV _{dr} /dt=20V/µs (Note 2)	- µs
tq	Turn-off time	1450	-	1800	I _{TM} =3000A, t _p =1000µs, di/dt=10A/µs, V _r =100V, V _{dr} =80%V _{DRM} , dV _{dr} /dt=200V/µs (Note 2)	
		-	-	0.0080	Double side cooled	K/W
R_{thJK}	Thermal resistance, junction to heatsink	-	-	0.0205	Cathode side cooled	K/W
		-	-	0.0133	Anode side cooled	K/W
F	Mounting force	60	-	70	(Note 3)	kN
Wt	Weight	-	1.15	-		kg

Notes: -

Unless otherwise stated T_j=125°C.
Standard test condition for tq dV_{dr}/dt=20V/μs. For other dV_{dr}/dt values please consult factory.
For other clamp forces please consult factory.

Notes on Ratings and Characteristics

1.0 Voltage Grade Table

Voltage Grade	Vdrm Vdsm Vrrm V	V _{RSM} V	V _D V _R DC V
60	6000	6100	3320
65	6500	6600	3600

2.0 Extension of Voltage Grades

This report is applicable to other and higher voltage grades when supply has been agreed by Sales/Production.

3.0 De-rating Factor

A blocking voltage de-rating factor of 0.13%/°C is applicable to this device for T_i below 25°C.

4.0 Repetitive dv/dt

Standard dv/dt is 1000V/µs.

5.0 Snubber Components

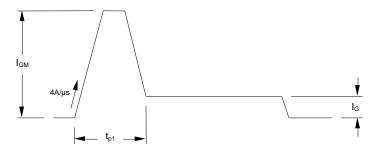
When selecting snubber components, care must be taken not to use excessively large values of snubber capacitor or excessively small values of snubber resistor. Such excessive component values may lead to device damage due to the large resultant values of snubber discharge current. If required, please consult the factory for assistance.

6.0 Rate of rise of on-state current

The maximum un-primed rate of rise of on-state current must not exceed 1000A/µs at any time during turn-on on a non-repetitive basis. For repetitive performance, the on-state rate of rise of current must not exceed 200A/µs at any time during turn-on. Note that these values of rate of rise of current apply to the total device current including that from any local snubber network.

7.0 Gate Drive

The nominal requirement for a typical gate drive is illustrated below. An open circuit voltage of at least 30V is assumed. This gate drive must be applied when using the full di/dt capability of the device.



The magnitude of I_{GM} should be between five and ten times I_{GT} , which is shown on page 2. Its duration (t_{p1}) should be 20µs or sufficient to allow the anode current to reach ten times I_L , whichever is greater. Otherwise, an increase in pulse current could be needed to supply the necessary charge to trigger. The 'back-porch' current I_G should remain flowing for the same duration as the anode current and have a magnitude in the order of 1.5 times I_{GT} .

8.0 Computer Modelling Parameters

8.1 Device Dissipation Calculations

$$\mathbf{I}_{\mathrm{AV}} = \frac{-\mathbf{V}_{\mathrm{0}} + \sqrt{\mathbf{V}_{\mathrm{0}} + 4 \cdot \mathrm{ff} \cdot \mathbf{r}_{\mathrm{s}} \cdot \mathbf{W}_{\mathrm{AV}}}}{2 \cdot \mathrm{ff} \cdot \mathbf{r}_{\mathrm{s}}} \qquad \text{and:} \qquad \begin{aligned} W_{\mathrm{AV}} = \frac{\Delta T}{R_{\mathrm{th}}} \\ \Delta T = T_{\mathrm{j}\,\mathrm{max}} - T_{\mathrm{Hs}} \end{aligned}$$

$$\Delta T = T$$

Where V₀=1.26V, r_T =0.41m Ω ,

 R_{th} = Supplementary thermal impedance, see table below.

ff = Form factor, see table below.

Supplementary Thermal Impedance							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave Double Side Cooled	0.0088	0.0087	0.0086	0.0085	0.0083	0.0081	0.0080
Square wave Cathode Side Cooled	0.0211	0.0210	0.0209	0.0208	0.0206	0.0205	0.0200
Sine wave Double Side Cooled	0.0087	0.0086	0.0085	0.0084	0.0081		
Sine wave Cathode Side Cooled	0.0210	0.0209	0.0208	0.0206	0.0204		

Form Factors							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave	3.46	2.45	2	1.73	1.41	1.15	1
Sine wave	3.98	2.78	2.22	1.88	1.57		

8.2 Calculating VT using ABCD Coefficients

The on-state characteristic I_T vs. V_T, on page 7 is represented in two ways;

- the well established Vo and rs tangent used for rating purposes and (i)
- (ii) a set of constants A, B, C, D, forming the coefficients of the representative equation for VT in terms of I_T given below:

$$V_T = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

The constants, derived by curve fitting software, are given below for both hot and cold characteristics. The resulting values for VT agree with the true device characteristic over a current range, which is limited to that plotted.

25°C Coefficients		125°C Coefficients	
А	1.494611104	Α	-0.171434796
В	-0.07333551	В	0.2655207
С	1.83115×10 ⁻⁴	С	4.68308×10 ⁻⁴
D	0.01395872	D	-0.01568942

8.3 D.C. Thermal Impedance Calculation

$$r_t = \sum_{p=1}^{p=n} r_p \cdot \left(1 - e^{\frac{-t}{\tau_p}}\right)$$

Where p = 1 to *n*, *n* is the number of terms in the series and:

- t = Duration of heating pulse in seconds.
- $r_t =$ Thermal resistance at time t.
- r_p = Amplitude of p_{th} term.
- τ_p = Time Constant of r_{th} term.

D.C. Double Side Cooled						
Term	1	2	3	4		
rp	3.836808×10 ³	2.300401×10 ³	1.342680×10 ³	4.747030×10 ⁴		
τρ	1.012675	0.2954374	0.06875831	9.711908×10 ³		

D.C. Cathode Side Cooled						
Term	1	2	3			
rp	0.01653008	3.46899×10 ³	5.233210×10 ⁴			
τρ	5.315577	0.1404311	9.722513×10 ³			

9.0 Reverse recovery ratings

(i) Q_{ra} is based on 50% I_{rm} chord as shown in Fig. 1

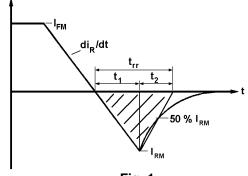


Fig. 1

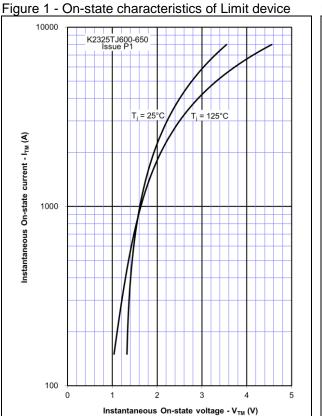
(ii) Q_{rr} is based on a 150µs integration time i.e.

$$Q_{rr} = \int_{0}^{600\mu s} i_{rr}.dt$$

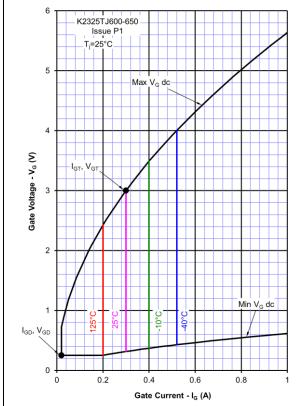
(iii)

K Factor =
$$\frac{t_1}{t_2}$$

<u>Curves</u>







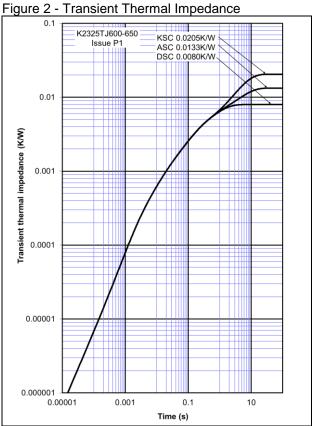
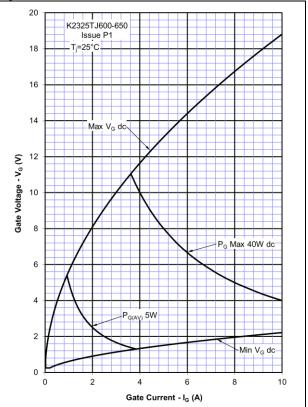


Figure 4 - Gate Characteristics - Power Curves





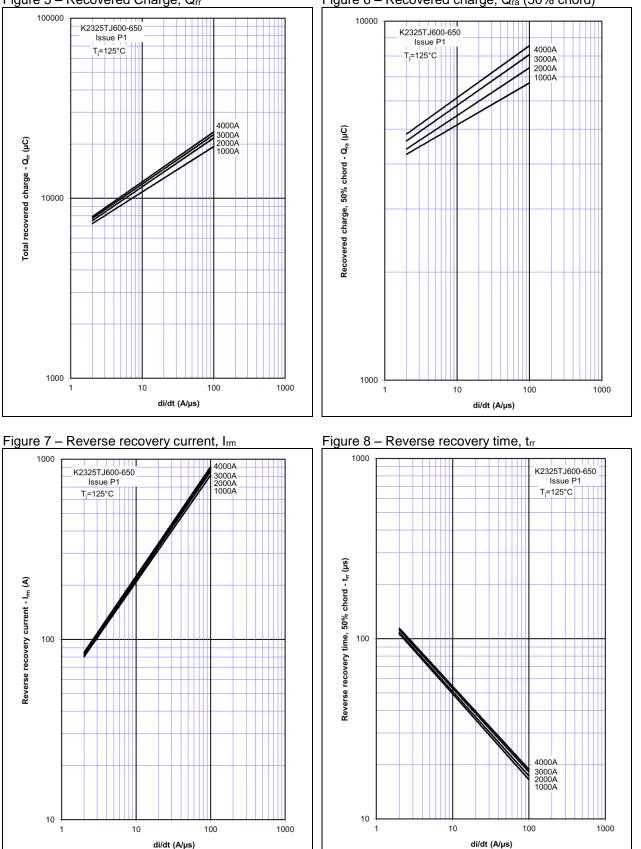


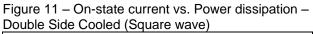
Figure 5 – Recovered Charge, Qrr

Figure 6 – Recovered charge, Q_{ra} (50% chord)



Double Side Cooled (Sine wave)

14000 K2325TJ600-650 Issue P1 180 12000 30 10000 Maximum forward dissipation (W) 8000 6000 4000 2000 0 0 500 1000 1500 2000 2500 3000 Mean forward current (A) (Whole cycle averaged)



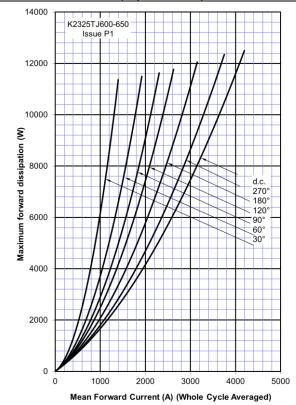


Figure 9 - On-state current vs. Power dissipation -Figure 10 – On-state current vs. Heatsink temperature - Double Side Cooled (Sine wave)

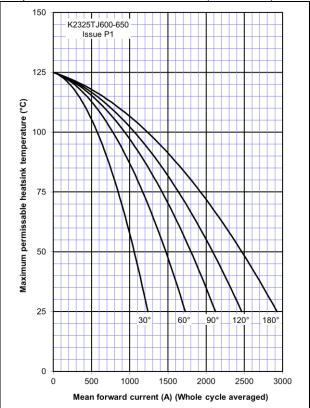
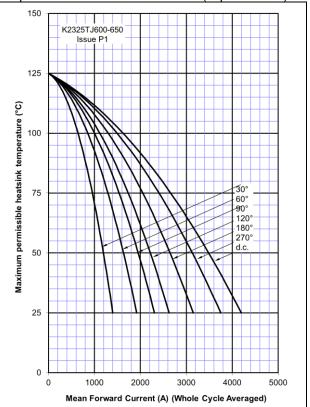


Figure 12 – On-state current vs. Heatsink temperature - Double Side Cooled (Square wave)





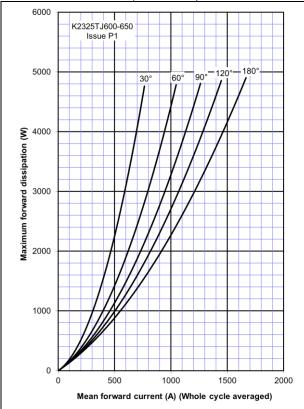


Figure 13 – On-state current vs. Power dissipation – Cathode Side Cooled (Sine wave)

Figure 14 – On-state current vs. Heatsink temperature - Cathode Side Cooled (Sine wave)

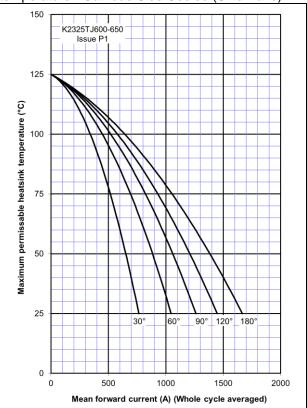


Figure 15 – On-state current vs. Power dissipation – Cathode Side Cooled (Square wave)

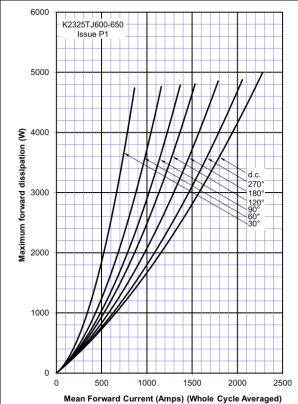
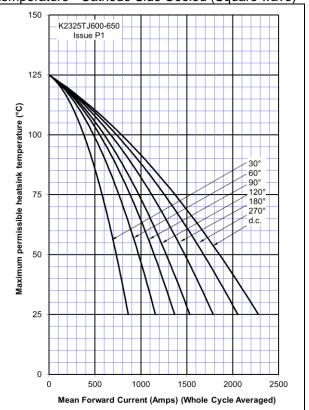


Figure 16 – On-state current vs. Heatsink temperature - Cathode Side Cooled (Square wave)



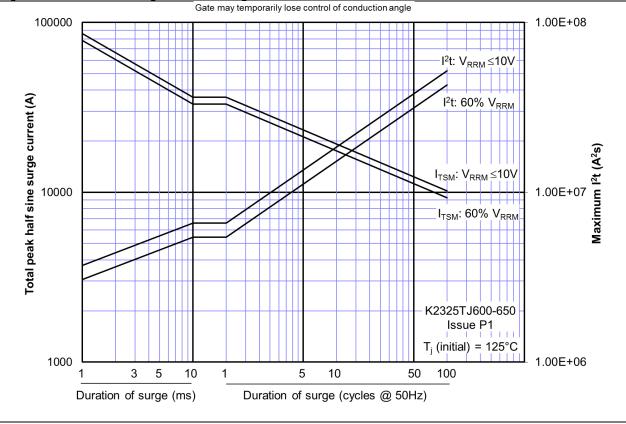


Figure 17 – Maximum surge and I²t Ratings

Outline Drawing & Ordering Information

